## BUD42D

## High Speed, High Gain Bipolar NPN Transistor Integrating an <br> Antisaturation Network and a Transient Voltage Suppression Capability

The BUD42D is a state-of-the-art bipolar transistor. Tight dynamic characteristics and lot to lot minimum spread make it ideally suitable for light ballast applications.

## Main Features:

- Free Wheeling Diode Built In
- Flat DC Current Gain
- Fast Switching Times and Tight Distribution
- "6 Sigma" Process Providing Tight and Reproducible Parameter Spreads
Two Versions:
- BUD42D-1: Case 369-07 for Insertion Mode
- BUD42D: Case 369A-13 for Surface Mount Mode


## MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: |
| Collector-Emitter Sustaining Voltage | $\mathrm{V}_{\text {CEO }}$ | 350 | Vdc |
| Collector-Base Breakdown Voltage | $\mathrm{V}_{\text {CBO }}$ | 650 | Vdc |
| Collector-Emitter Breakdown Voltage | $\mathrm{V}_{\text {CES }}$ | 650 | Vdc |
| Emitter-Base Voltage | $\mathrm{V}_{\text {Ebo }}$ | 9 | Vdc |
| Collector Current - Continuous <br> - Peak (Note 1) | $\begin{gathered} \mathrm{IC}_{\mathrm{C}} \\ \mathrm{I}_{\mathrm{CM}} \end{gathered}$ | $\begin{aligned} & 4.0 \\ & 8.0 \end{aligned}$ | Adc |
| Base Current - Continuous <br> - Peak (Note 1) | $\begin{gathered} \mathrm{I}_{\mathrm{B}} \\ \mathrm{I}_{\mathrm{BM}} \end{gathered}$ | $\begin{aligned} & 1.0 \\ & 2.0 \end{aligned}$ | Adc |
| *Total Device Dissipation @ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ *Derate above $25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | $\begin{aligned} & 25 \\ & 0.2 \end{aligned}$ | Watt <br> $\mathrm{W} /{ }^{\circ} \mathrm{C}$ |
| Operating and Storage Temperature | $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\mathrm{stg}}$ | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |

TYPICAL GAIN

| Typical Gain @ $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A}, \mathrm{~V}_{\mathrm{CE}}=2 \mathrm{~V}$ | $\mathrm{~h}_{\mathrm{FE}}$ | 13 | - |
| :--- | :--- | :--- | :--- |
| Typical Gain @ $\mathrm{I}_{\mathrm{C}}=0.3 \mathrm{~A}, \mathrm{~V}_{\mathrm{CE}}=1 \mathrm{~V}$ | $\mathrm{~h}_{\mathrm{FE}}$ | 16 | - |

## THERMAL CHARACTERISTICS

| Characteristic | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: |
| Thermal Resistance - <br> Junction-to-Case | $\mathrm{R}_{\text {өJC }}$ | 5.0 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Thermal Resistance - <br> Junction-to-Ambient | $\mathrm{R}_{\text {өJA }}$ | 71.4 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Maximum Lead Temperature for Soldering <br> Purposes: $1 / 8^{\prime \prime}$ from Case for 5 seconds | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |

[^0]
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## 4 AMPERES 650 VOLTS 25 WATTS POWER TRANSISTOR




DPAK CASE 369 STYLE 1


DPAK CASE 369A STYLE 1

MARKING DIAGRAMS


ORDERING INFORMATION

| Device | Package | Shipping |
| :---: | :---: | :---: |
| BUD42D | DPAK | 75 Units/Rail |
| BUD42D-1 | DPAK | 75 Units/Rail |

## BUD42D

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |

OFF CHARACTERISTICS

| Collector-Emitter Sustaining Voltage$\left(I_{C}=100 \mathrm{~mA}, \mathrm{~L}=25 \mathrm{mH}\right)$ |  | $\mathrm{V}_{\text {CEO(sus) }}$ | 350 | 430 | - | Vdc |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Collector-Base Breakdown Voltage $\left(I_{\mathrm{CBO}}=1 \mathrm{~mA}\right)$ |  | $\mathrm{V}_{\text {CBO }}$ | 650 | 780 | - | Vdc |
| Emitter-Base Breakdown Voltage $\left(\mathrm{I}_{\mathrm{EBO}}=1 \mathrm{~mA}\right)$ |  | $\mathrm{V}_{\text {EBO }}$ | 9.0 | 12 | - | Vdc |
| Collector Cutoff Current $\left(\mathrm{V}_{\mathrm{CE}}=\text { Rated } \mathrm{V}_{\mathrm{CEO}}, \mathrm{I}_{\mathrm{B}}=0\right)$ | @ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ <br> @ $\mathrm{T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | $I_{\text {CEO }}$ | - | - | $\begin{aligned} & 100 \\ & 200 \end{aligned}$ | $\mu \mathrm{Adc}$ |
| Collector Cutoff Current ( $\mathrm{V}_{\mathrm{CE}}=$ Rated $\mathrm{V}_{\mathrm{CES}}, \mathrm{V}_{\mathrm{EB}}=0$ ) | @ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ <br> @ $\mathrm{T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | $I_{\text {CES }}$ |  |  | $\begin{gathered} 10 \\ 200 \end{gathered}$ | $\mu \mathrm{Adc}$ |
| $\begin{array}{r} \hline \text { Emitter-Cutoff Current } \\ \left(\mathrm{V}_{\mathrm{EB}}=9 \mathrm{Vdc}, \mathrm{I}_{\mathrm{C}}=0\right) \end{array}$ |  | Iebo | - | - | 100 | $\mu \mathrm{Adc}$ |

ON CHARACTERISTICS

| Base-Emitter Saturation Voltage ( $\mathrm{I}_{\mathrm{C}}=1 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=0.2 \mathrm{Adc}$ ) | $\mathrm{V}_{\mathrm{BE} \text { (sat) }}$ | - | 0.85 | 1.2 | Vdc |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Collector-Emitter Saturation Voltage $\left(\mathrm{I}_{\mathrm{C}}=2 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=0.5 \mathrm{Adc}\right)$ | $\mathrm{V}_{\mathrm{CE} \text { (sat) }}$ | - | 0.2 | 1.0 | Vdc |
| DC Current Gain $\begin{aligned} & \left(\mathrm{I}_{\mathrm{C}}=1 \mathrm{Adc}, \mathrm{~V}_{\mathrm{CE}}=2 \mathrm{Vdc}\right) \\ & \left(\mathrm{I}_{\mathrm{C}}=2 \mathrm{Adc}, \mathrm{~V}_{\mathrm{CE}}=5 \mathrm{Vdc}\right) \end{aligned}$ | $\mathrm{h}_{\text {FE }}$ | $\begin{aligned} & 8.0 \\ & 10 \end{aligned}$ | $\begin{aligned} & 13 \\ & 12 \end{aligned}$ | - | - |

## DIODE CHARACTERISTICS

| Forward Diode Voltage <br> $\left(\mathrm{I}_{\mathrm{EC}}=1.0\right.$ Adc $)$ | $\mathrm{V}_{\mathrm{EC}}$ |  |  | V |
| :--- | :---: | :---: | :---: | :---: | :---: |

SWITCHING CHARACTERISTICS: Resistive Load (D.C. $\leq 10 \%$, Pulse Width $=40 \mu \mathrm{~s}$ )

| Turn-Off Time $\left(\mathrm{I}_{\mathrm{C}}=1.2 \mathrm{Adc}, \mathrm{I}_{\mathrm{B} 1}=0.4 \mathrm{~A}, \mathrm{I}_{\mathrm{B} 2}=0.1 \mathrm{~A}, \mathrm{~V}_{\mathrm{CC}}=300 \mathrm{~V}\right)$ | $\mathrm{T}_{\text {off }}$ | 4.6 | - | 6.55 | $\mu \mathrm{S}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Fall Time $\left(\mathrm{I}_{\mathrm{C}}=2.5 \mathrm{Adc}, \mathrm{I}_{\mathrm{B} 1}=\mathrm{I}_{\mathrm{B} 2}=0.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{CC}}=150 \mathrm{~V}, \mathrm{~V}_{\mathrm{BE}}=-2 \mathrm{~V}\right)$ | $\mathrm{T}_{\mathrm{f}}$ | - | - | 0.8 | $\mu \mathrm{s}$ |

## DYNAMIC SATURATION VOLTAGE



TYPICAL STATIC CHARACTERISTICS


Figure 1. DC Current Gain @ $\mathrm{V}_{\mathrm{CE}}=1 \mathrm{~V}$


Figure 3. Collector Saturation Region


Figure 5. Collector-Emitter Saturation Voltage


Figure 2. DC Current Gain @ $\mathrm{V}_{\mathrm{CE}}=5 \mathrm{~V}$


Figure 4. Collector-Emitter Saturation Voltage


Figure 6. Collector-Emitter Saturation Voltage

## TYPICAL STATIC CHARACTERISTICS



Figure 7. Base-Emitter Saturation Region


Figure 9. Base-Emitter Saturation Region


Figure 8. Base-Emitter Saturation Region


Figure 10. Forward Diode Voltage

TYPICAL SWITCHING CHARACTERISTICS


Figure 11. Capacitance


Figure 13. Resistive Switching, $t_{\text {on }}$


Figure 15. Inductive Storage Time, $\mathbf{t}_{\mathrm{si}} @ \mathrm{~h}_{\mathrm{FE}}=5$


Figure 12. $\mathrm{B}_{\mathrm{VCER}}=\mathrm{f}\left(\mathrm{R}_{\mathrm{BE}}\right)$


Figure 14. Resistive Switching, $\mathrm{t}_{\text {off }}$


Figure 16. Inductive Storage Time, $\mathbf{t}_{\mathrm{si}} @ \mathrm{~h}_{\mathrm{FE}}=10$

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TYPICAL SWITCHING CHARACTERISTICS


Figure 17. Inductive Fall and Cross Over Time, $\mathrm{t}_{\mathrm{fi}}$ and $\mathrm{t}_{\mathrm{c}} @ \mathrm{~h}_{\mathrm{FE}}=5$


Figure 19. Inductive Cross Over Time, $\mathrm{t}_{\mathrm{c}} @ \mathrm{~h}_{\mathrm{FE}}=10$


Figure 21. Inductive Fall Time, $\mathbf{t}_{\mathbf{f}}$


Figure 18. Inductive Fall Time, $\mathrm{t}_{\mathrm{fi}} @ \mathrm{~h}_{\mathrm{FE}}=10$


Figure 20. Inductive Storage Time, $\mathbf{t}_{\mathbf{s i}}$


Figure 22. Inductive Cross Over Time, $\mathbf{t}_{\mathbf{c}}$


Figure 23. Inductive Storage Time, $\mathbf{t}_{\mathbf{s i}}$


Figure 25. Dynamic Saturation Voltage Measurements


Figure 24. Forward Recovery Time, $\mathrm{t}_{\mathrm{fr}}$


Figure 26. Inductive Switching Measurements

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TYPICAL SWITCHING CHARACTERISTICS

Table 1. Inductive Load Switching Drive Circuit

$V_{\text {(BR)CEO(sus) }}$
$L=10 \mathrm{mH}$
$\mathrm{R}_{\mathrm{B} 2}=\infty$
$\mathrm{V}_{\mathrm{CC}}=20$ Volts
$\mathrm{I}_{\mathrm{C}(\mathrm{pk})}=100 \mathrm{~mA}$

| Inductive Switching | RBSOA |
| :--- | :--- |
| $L=200 \mu \mathrm{H}$ | $\mathrm{L}=500 \mu \mathrm{H}$ |
| $\mathrm{R}_{\mathrm{B} 2}=0$ | $\mathrm{R}_{\mathrm{B} 2}=0$ |
| $\mathrm{~V}_{\mathrm{CC}}=15$ Volts | $\mathrm{V}_{\mathrm{CC}}=15$ Volts |
| $\mathrm{R}_{\mathrm{B} 1}$ selected for | $\mathrm{R}_{\mathrm{B} 1}$ selected for |
| desired $\mathrm{I}_{\mathrm{B} 1}$ | desired $\mathrm{I}_{\mathrm{B} 1}$ |



Figure 27. $\mathrm{t}_{\mathrm{fr}}$ Measurement
MAXIMUM RATINGS


Figure 28. Forward Bias Safe Operating Area

## BUD42D



Figure 30. Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $\mathrm{I}_{\mathrm{C}}-\mathrm{V}_{\mathrm{CE}}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 28 is based on $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C} ; \mathrm{T}_{\mathrm{j}(\mathrm{pk})}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to $10 \%$ but must be derated when $\mathrm{T}_{\mathrm{C}}>25^{\circ} \mathrm{C}$. Second Breakdown limitations do not derate like thermal limitations. Allowable current at the voltages shown on

Figure 28 may be found at any case temperature by using the appropriate curve on Figure 30.
$\mathrm{T}_{\mathrm{j}(\mathrm{pk})}$ may be calculated from the data in Figure 31. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base to emitter junction reverse biased. The safe level is specified as reverse biased safe operating area (Figure 29). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.


Figure 31. Thermal Response

## BUD42D

Minimum Pad Sizes Recommended for Surface Mounted Applications


$$
\left(\frac{\mathrm{mm}}{\text { inches }}\right)
$$

## TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones, and a figure for belt speed. Taken together, these control settings make up a heating "profile" for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 32 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows temperature versus time.

The line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between $177-189^{\circ} \mathrm{C}$. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.


Figure 32. Typical Solder Heating Profile

## PACKAGE DIMENSIONS

DPAK
CASE 369A-13
ISSUE AB


DPAK STRAIGHT LEADS
CASE 369-07
ISSUE M


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI

Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

|  | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |
| A | 0.235 | 0.250 | 5.97 | 6.35 |
| B | 0.250 | 0.265 | 6.35 | 6.73 |
| C | 0.086 | 0.094 | 2.19 | 2.38 |
| D | 0.027 | 0.035 | 0.69 | 0.88 |
| E | 0.033 | 0.040 | 0.84 | 1.01 |
| F | 0.037 | 0.047 | 0.94 | 1.19 |
| G | 0.090 BSC | 2.29 BSC |  |  |
| H | 0.034 | 0.040 | 0.87 | 1.01 |
| J | 0.018 | 0.023 | 0.46 | 0.58 |
| K | 0.350 | 0.380 | 8.89 | 9.65 |
| R | 0.175 | 0.215 | 4.45 | 5.46 |
| S | 0.050 | 0.090 | 1.27 | 2.28 |
| V | 0.030 | 0.050 | 0.77 | 1.27 |

STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
. CONTROLLING DIMENSION: INCH.

| DIM | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |
| A | 0.235 | 0.250 | 5.97 | 6.35 |
| B | 0.250 | 0.265 | 6.35 | 6.73 |
| C | 0.086 | 0.094 | 2.19 | 2.38 |
| D | 0.027 | 0.035 | 0.69 | 0.88 |
| E | 0.033 | 0.040 | 0.84 | 1.01 |
| F | 0.037 | 0.047 | 0.94 | 1.19 |
| G | 0.180 BSC |  | 4.58 BSC |  |
| H | 0.034 | 0.040 | 0.87 | 1.01 |
| J | 0.018 | 0.023 | 0.46 | 0.58 |
| K | 0.102 | 0.114 | 2.60 | 2.89 |
| L | 0.090 BSC |  | 2.29 BSC |  |
| R | 0.175 | 0.215 | 4.45 | 5.46 |
| S | 0.020 | 0.050 | 0.51 | 1.27 |
| U | 0.020 | --- | 0.51 | --- |
| V | 0.030 | 0.050 | 0.77 | 1.27 |
| Z | 0.138 | --- | 3.51 | --- |

STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR


#### Abstract

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[^0]:    1. Pulse Test: Pulse Width $=5.0 \mathrm{~ms}$, Duty Cycle $=10 \%$
